Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/693,737	CHANG ET AL.	
Examiner	Art Unit	
Pichard I Chiesa	1724	

SEARCHED							
Class	Subclass	Date	Examiner				
96	60-63, 95- 97	4/18/2005	RLC				
ABOVE							
UPD	ATED.						
96	98						
55	DIG.38	6/10/05	R.L.C.				
			3.4				

INT	INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner		
96	15-100	6/10/05	R.L.C.		
95	57-81	6/10/05	R. L.C.		

SEARCH NOTES (INCLUDING SEARCH STRATEGY)					
	DATE	EXMR			
PALM Inventors' Names and Assignee (Industrial Technology Research Institute) searches.	4/16/2005	RLC			
ABOVE					
UPDATED.	6/10/05	R.L.C.			